

# APML-600JV, APML-600JT

## Automotive Photo MOSFET

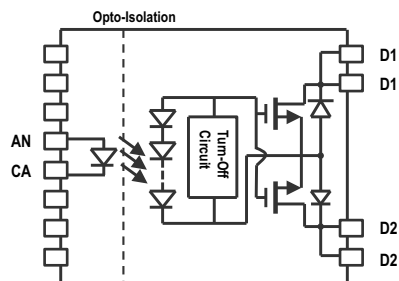
### Description

The Broadcom® APML-600JV/JT is a high-voltage Photo MOSFET that is designed for automotive applications. APML-600JV/JT consists of an AlGaAs infrared light-emitting diode (LED) input stage that is optically coupled to a high-voltage output detector circuit. The detector consists of a high-speed photovoltaic diode array and driver circuitry to switch on/off two discrete high voltage MOSFETs. The Photo MOSFET turns on (contact closes) with a minimum input current of 1.5 mA through the input LED. The Photo MOSFET turns off (contact opens) with an input voltage of 0.4V or less.

The APML-600JV/JT is equivalent to 1 Form A Electromechanical Relays (EMR) and is available in 16-pin SOIC package.

Broadcom R<sup>2</sup>Coupler™ provides reinforced insulation and reliability that delivers safe signal isolation critical in automotive and high temperature industrial applications.

### Functional Diagram



### Truth Table

LED	Output
OFF	Open
ON	Close

**CAUTION!** It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be induced by ESD. The components featured in this data sheet are not to be used in military or aerospace applications or environments.

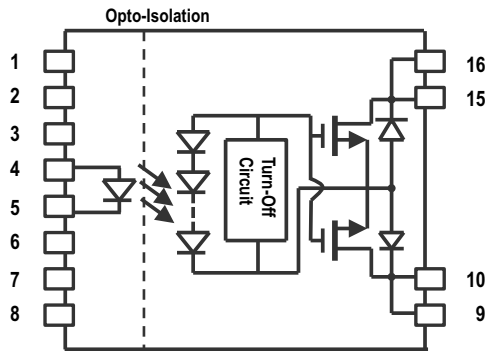
### Features

- Compact solid-state bidirectional signal switch
- Qualified to AEC-Q101 test guidelines
- Automotive temperature range:
  - APML-600JV:  $T_A = -40^{\circ}\text{C}$  to  $+105^{\circ}\text{C}$
  - APML-600JT:  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$
- Breakdown Voltage,  $V_{O(OFF)}$ : 1500V at  $I_{O(OFF)} = 250 \mu\text{A}$
- Avalanche-rated MOSFETs
- Low off-state leakage:
  - APML-600JV:  $I_{O(OFF)} < 500 \text{ nA}$  at  $V_{DS} = 1000\text{V}$
  - APML-600JT:  $I_{O(OFF)} < 1000 \text{ nA}$  at  $V_{DS} = 1000\text{V}$
- On-resistance:  $R_{ON} < 900\Omega$  at  $I_O = 1 \text{ mA}$
- Turn-on time:  $T_{ON} < 2.0 \text{ ms}$
- Turn-off time:  $T_{OFF} < 0.5 \text{ ms}$
- Package: 300 mil SO-16
- Creepage and Clearance  $\geq 8 \text{ mm}$  (input-output)
- Creepage  $> 5 \text{ mm}$  (between drain pins of MOSFETs)
- Safety and Regulatory approvals:
  - IEC/EN/DIN EN 60747-5-5
  - Maximum Working Insulation Voltage 1414  $V_{PEAK}$
  - UL/cUL 1577, 5000  $V_{RMS}$  for 1 minute

### Applications

- Battery insulation resistance measurement/leakage detection
- Battery Management System (BMS)

Package Pinout



Pin Description

Pin Number	Name	Description
1, 2, 6, 7, 8	NC	No Connection
3	NC	Do not connect (internally connected to Pin 5)
4	AN	Anode
5	CA	Cathode
9, 10	D2	Drain 2 (internally connected)
15, 16	D1	Drain 1 (internally connected)

Ordering Information

Part Number	Option (RoHS Compliant)	Package	Surface Mount	Tape and Reel	UL 5000V <sub>rms</sub> / 1 Minute Rating	IEC 60747-5-5 EN/DIN EN 60747-5-5	Quantity
APML-600JV	-000E	SO-16	X	—	X	X	45 per tube
	-500E		X	X	X	X	850 per reel
APML-600JT	-000E	SO-16	X	—	X	X	45 per tube
	-500E		X	X	X	X	850 per reel

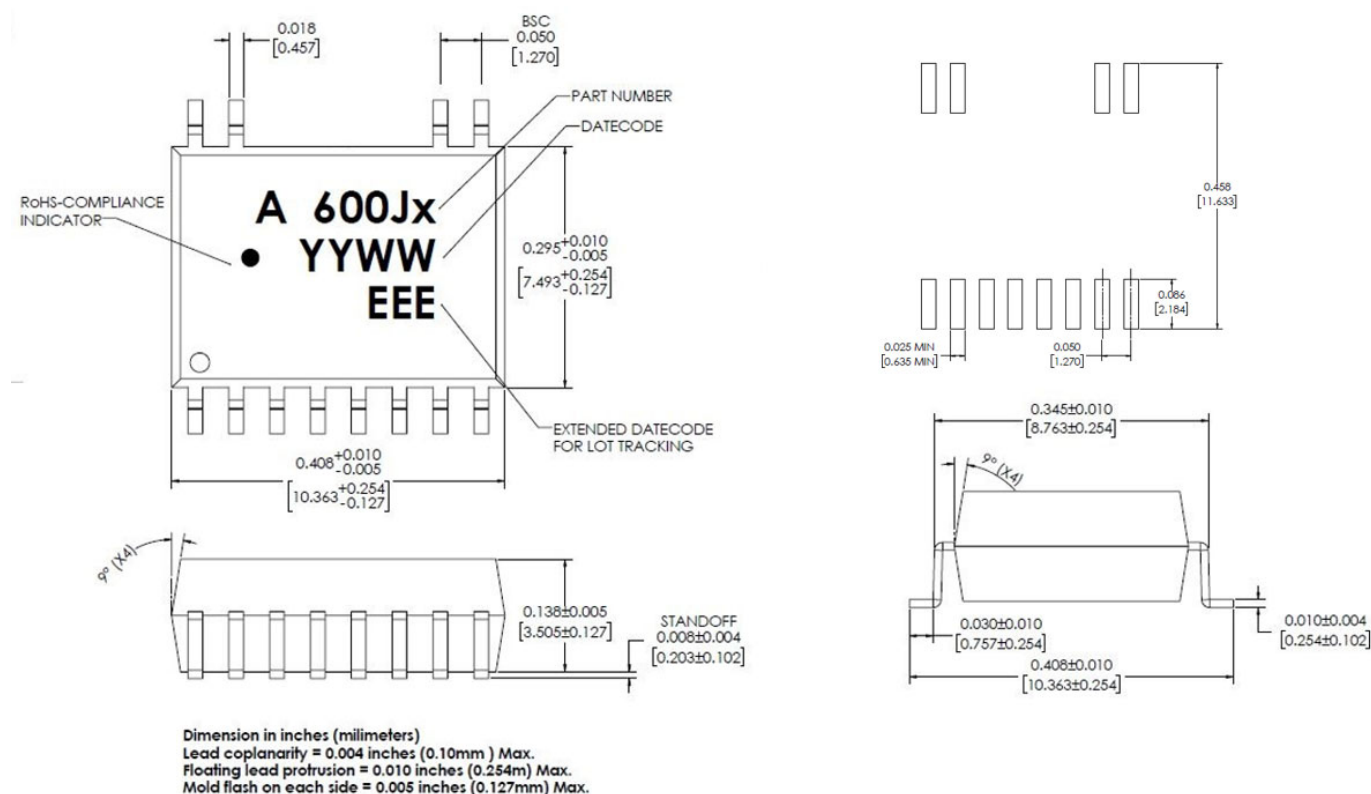
To order, choose a part number from the part number column and combine with the desired option from the option column to form an order entry.

Example 1:

APML-600JT-500E to order product of SO-16 Surface-Mount package in Tape and Reel packaging with IEC/EN/DIN EN 60747-5-5 Safety Approval in RoHS compliant.

Option data sheets are available. Contact your Broadcom sales representative or authorized distributor for information.

## Package Outline Drawing



## Recommended PB-Free IR Profile

Recommended reflow condition as per JEDEC Standard, J-STD-020 (latest revision).

**NOTE:** Non-halide flux should be used.

## Regulatory Information

The APML-600JV/JT are approved by the following organizations:

UL/cUL	IEC/EN/DIN EN 60747-5-5
UL 1577, component recognition program up to $V_{ISO} = 5 \text{ kV}_{RMS}$ Approved under CAN/CSA-C22.2 No. 62368-1	Maximum Working Insulation Voltage, $V_{IORM} = 1414 \text{ V}_{PEAK}$ Highest Allowable Overvoltage, $V_{IOTM} = 6000 \text{ V}_{PEAK}$

## Insulation and Safety-Related Specifications

Parameter	Symbol	Value	Units	Conditions
Minimum External Air Gap (Clearance)	L(101)	8.3	mm	Measured from input terminals to output terminals, shortest distance through air.
Minimum External Tracking (Creepage)	L(102)	8.3	mm	Measured from input terminals to output terminals, shortest distance path along body.
Minimum Internal Plastic Gap (Internal Clearance)		0.5	mm	The shortest straight line distance through insulation between conductor to conductor.
Tracking Resistance (Comparative Tracking Index)	CTI	> 600	V	IEC 60695

## IEC/EN/DIN EN60747-5-5 Insulation Characteristics

Description	Symbol	Characteristic	Units
Installation Classification per DIN VDE 0110/1.89, Table 1 For Rated Mains Voltage < 600 V <sub>RMS</sub> For Rated Mains Voltage < 1000 V <sub>RMS</sub>		I-III I-II	
Climatic Classification		40/125/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	V <sub>IORM</sub>	1414	V <sub>PEAK</sub>
Input to Output Test Voltage, Method b <sup>a</sup> V <sub>IORM</sub> × 1.875 = V <sub>PR</sub> , 100% Production Test with t <sub>m</sub> = 1s, Partial discharge < 5 pC	V <sub>PR</sub>	2651	V <sub>PEAK</sub>
Input to Output Test Voltage, Method a <sup>a</sup> V <sub>IORM</sub> × 1.6 = V <sub>PR</sub> , Type and Sample Test, t <sub>m</sub> = 10s, Partial Discharge < 5 pC	V <sub>PR</sub>	2262	V <sub>PEAK</sub>
Highest Allowable Overvoltage <sup>a</sup> (Transient Overvoltage t <sub>ini</sub> = 60s)	V <sub>IOTM</sub>	6000	V <sub>PEAK</sub>
Safety-Limiting Values – Maximum Values Allowed in the Event of a Failure <sup>b</sup> Ambient Safety Temperature Input Current Output Power	T <sub>S</sub> I <sub>S,INPUT</sub> P <sub>S,OUTPUT</sub>	175 400 1200	°C mA mW
Insulation Resistance at T <sub>S</sub> , V <sub>IO</sub> = 500V	R <sub>S</sub>	> 10 <sup>9</sup>	Ω

- a. Refer to the optocoupler section of the Isolation and Control Components Designer's Catalog, under Product Safety Regulation section IEC/EN/DIN EN 60747-5-5, for a detailed description of Method a and Method b partial discharge test profiles.
- b. Isolation characteristics are guaranteed only within the safety maximum ratings, which must be ensured by protective circuits in application. Surface-mount classification is Class A in accordance with CECC 00802.

## Absolute Maximum Ratings

All specifications at  $T_A = 25^\circ\text{C}$  unless otherwise specified.

Parameter		Symbol	Min.	Max.	Units	Notes
Storage Temperature		$T_S$	-55	150	$^\circ\text{C}$	
Operating Ambient Temperature		$T_A$	-40	125	$^\circ\text{C}$	
Junction Temperature		$T_J$	-40	150	$^\circ\text{C}$	
Input Current	Average	$I_{F(\text{avg})}$	—	10	mA	a
	Surge (50% duty cycle)	$I_{F(\text{surge})}$	—	20	mA	a
Reverse Input Voltage		$BV_R$	—	6	V	a
Input Power Dissipation		$P_{IN}$	—	100	mW	
Output Load Current		$I_O$	—	30	mA	
Output Avalanche Current		$I_{AV}$	—	0.6	mA	b
Output Power Dissipation		$P_O$	—	1000	mW	
Lead Soldering Cycle	Temperature		—	260	$^\circ\text{C}$	
	Time		—	10	s	
Solder Reflow Temperature Profile		Recommended reflow condition as per JEDEC Standard J-STD-020 (latest revision)				

a.  $T_A = -40^\circ\text{C}$  to  $125^\circ\text{C}$

b.  $t_m = 1$  minute, duty cycle = 0.1%, cumulative of 5 minutes over lifetime.

## Recommended Operating Conditions

Parameter	Symbol	Device	Min.	Max.	Units	Notes
Input Current (ON)	$I_{F(\text{ON})}$	—	1.5	5	mA	
Input Voltage (OFF)	$V_{F(\text{OFF})}$	—	-5	0.4	V	
Operating Temperature	$T_A$	APML-600JV	-40	105	$^\circ\text{C}$	
		APML-600JT	-40	125	$^\circ\text{C}$	
Continuous Load Voltage	$ V_O $	—	—	1000	$V_{DC}$	a
Load Current	$ I_O $	—	—	20	mA	b

a.  $V_O$  is the voltage across output terminals, pins 9, 10 and pins 15, 16.

b.  $I_O$  is the current across output terminals, pins 9, 10 and pins 15, 16.

## Electrical Specifications (DC)

Unless otherwise specified, all minimum/maximum specifications are over recommended operating conditions. All typical values at  $T_A = 25^\circ\text{C}$ ,  $I_F = 5\text{ mA}$ .

Parameter	Symbol	Device	Min.	Typ.	Max.	Units	Test Conditions	Figure	Notes
Input Reverse Breakdown Voltage	$V_R$	—	5	—	—	V	$I_R = 10\text{ }\mu\text{A}$		
Input Forward Voltage	$V_F$	—	1.2	1.41	1.75	V	$I_F = 5\text{ mA}$	1	
Output Withstand Voltage	$ V_{O(OFF)} $	—	1500	1690	—	V	$I_{O(OFF)} = 250\text{ }\mu\text{A}$ , $T_A = 25^\circ\text{C}$	3	a, b
Output Leakage Current	$ I_{O(OFF)} $	APML-600JV	—	0.1	500	nA	$V_{O(OFF)} = 1000\text{V}$	4	a
		APML-600JT	—	0.1	1000	nA	$V_{O(OFF)} = 1000\text{V}$	4	a
Output Capacitance	$C_{OUT}$	—	—	60	—	pF	$V_O = 0\text{V}$ , $f = 1\text{ MHz}$	7	a
Output On-Resistance	$R_{ON}$	—	—	310	900	$\Omega$	$I_O = 1\text{ mA}$	8	
		—	—	200	500	$\Omega$	$I_O = 20\text{ mA}$	8	

a. Device is in OFF state with  $V_F < 0.4\text{V}$ .

b. Per AEC-Q101, device performance is demonstrated with high temperature reverse bias stress at 1200V (80% of rated voltage).

## Switching Specifications (AC)

Unless otherwise specified, all Minimum/Maximum specifications are over recommended operating conditions. All typical values at  $T_A = 25^\circ\text{C}$ .

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions	Figure	Notes
Turn-On Time	$T_{ON}$	—	0.3	2.0	ms	$I_F = 1.5\text{ mA}$ , $V_{DD} = 40\text{V}$ , $R_{LOAD} = 20\text{ k}\Omega$	9, 11	
Turn-Off Time	$T_{OFF}$	—	0.05	0.5	ms	$I_F = 1.5\text{ mA}$ , $V_{DD} = 40\text{V}$ , $R_{LOAD} = 20\text{ k}\Omega$	10, 12	

## Package Characteristics

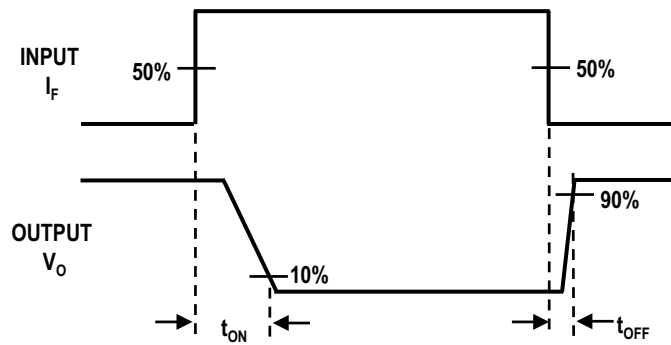
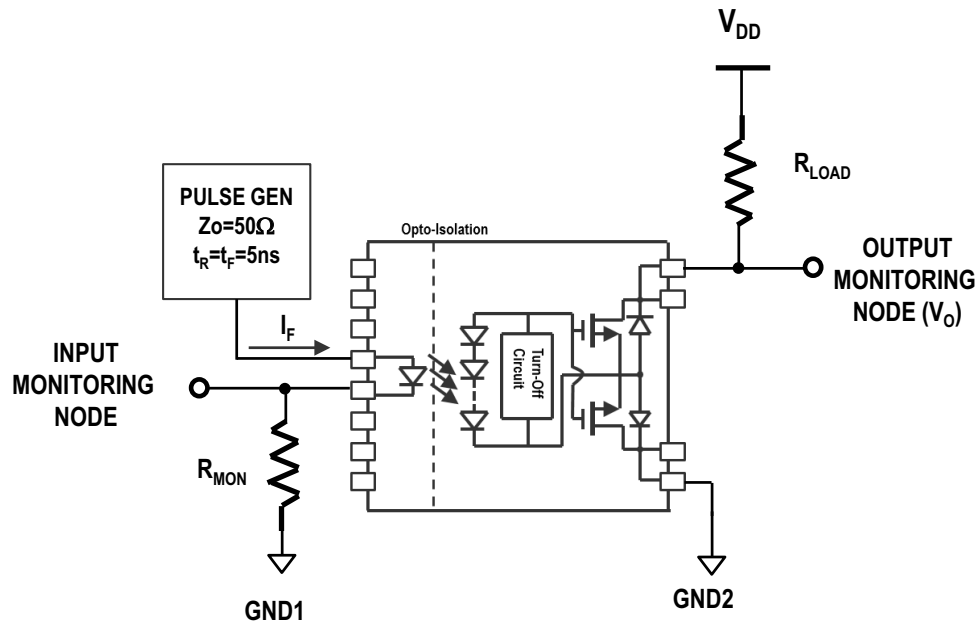
Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions	Figure	Notes
Input-Output Momentary Withstand Voltage <sup>a</sup>	$V_{ISO}$	5000	—	—	$V_{RMS}$	$RH \leq 50\%$ , $t = 1\text{ minute}$ , $T_A = 25^\circ\text{C}$		b, c
Input-Output Resistance	$R_{I-O}$	$10^9$	$10^{14}$	—	$\Omega$	$V_{I-O} = 1000V_{DC}$		b
Input-Output Capacitance	$C_{I-O}$	—	0.6	—	pF	$f = 1\text{ MHz}$ , $V_{I-O} = 0V_{DC}$		b

a. The Input-Output Momentary Withstand Voltage is a dielectric voltage rating that should not be interpreted as an input-output continuous voltage rating.

b. Device considered a two terminal device: pins 1 to 8 shorted together, and pins 9, 10, 15 and 16 shorted together.

c. In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage  $\geq 6000 V_{RMS}$  for 1 second.

## Switching Test Circuit and Waveform



## Typical Characteristic Curves

Figure 1: LED Forward Current vs. LED Forward Voltage

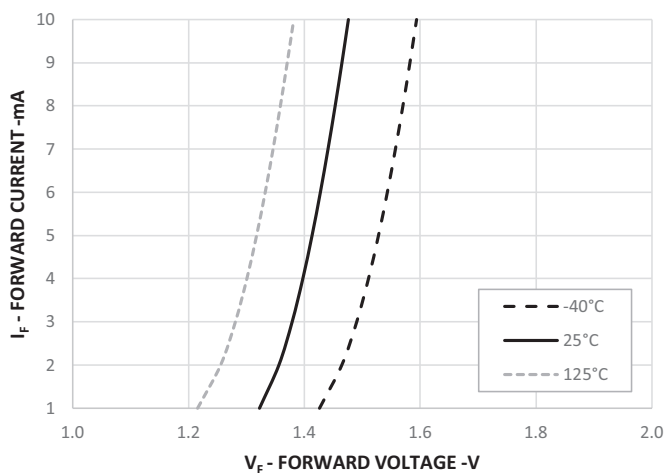


Figure 2: LED Forward Current Threshold vs Temperature

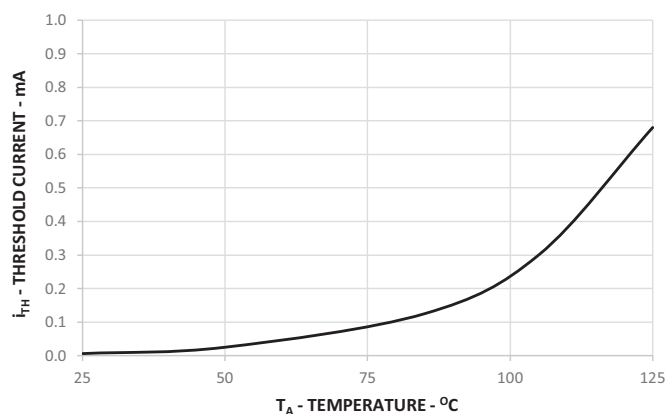


Figure 3: Output Withstand Voltage vs. Temperature (Test Condition:  $I_O = 250 \mu A$ )

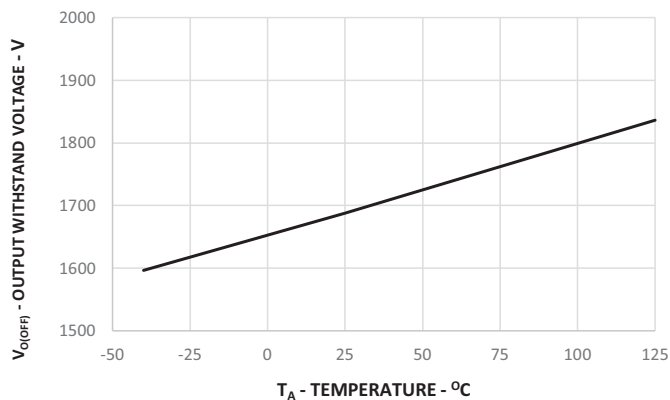


Figure 4: Output Leakage Current vs. Temperature (Test Condition:  $V_O = 1000V$ )

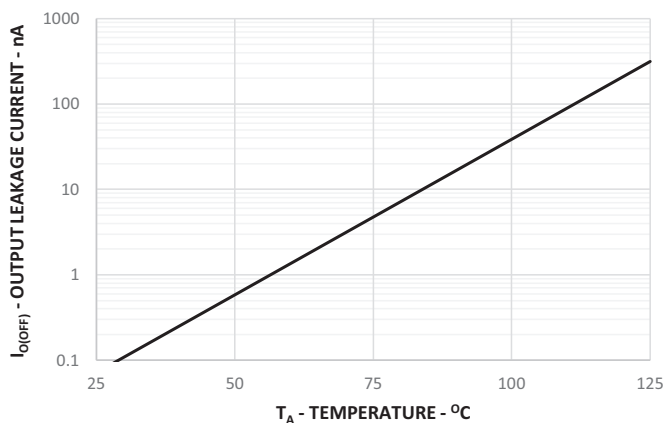


Figure 5: Output Leakage Current vs. Load Voltage (Test Condition:  $T_A = 25^\circ C$ )

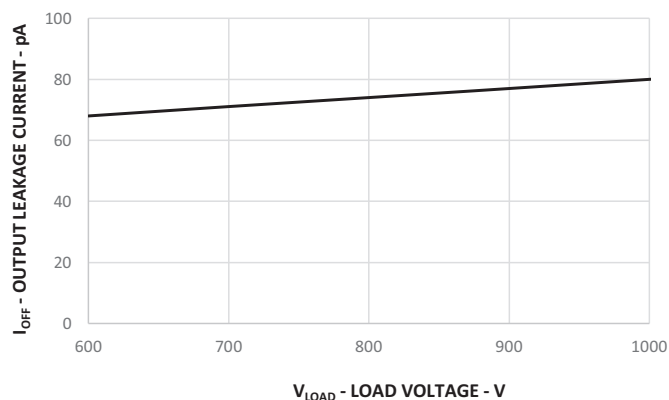
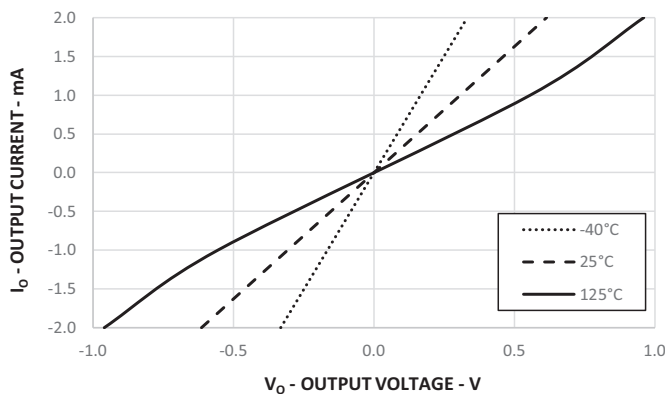
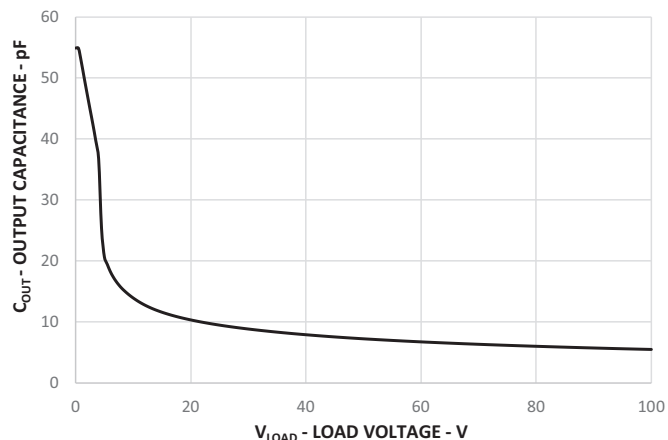


Figure 6: Output Current vs. Output Voltage

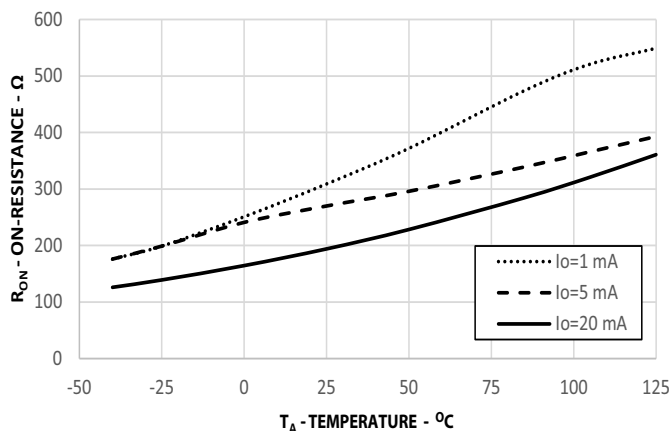




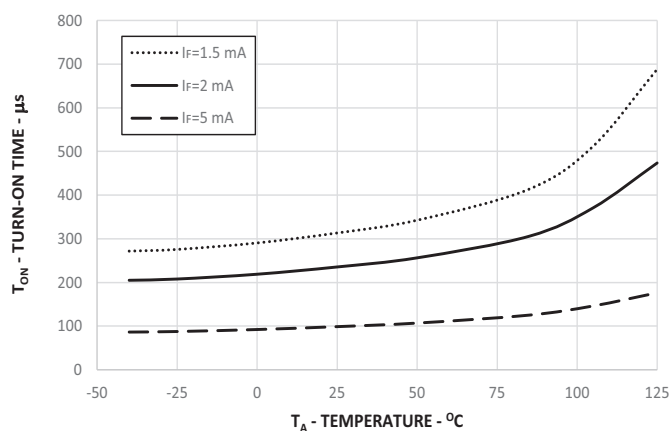
**Figure 7: Output Capacitance vs. Load Voltage**  
(Test Condition:  $f = 1 \text{ MHz}$ ,  $T_A = 25^\circ\text{C}$ )



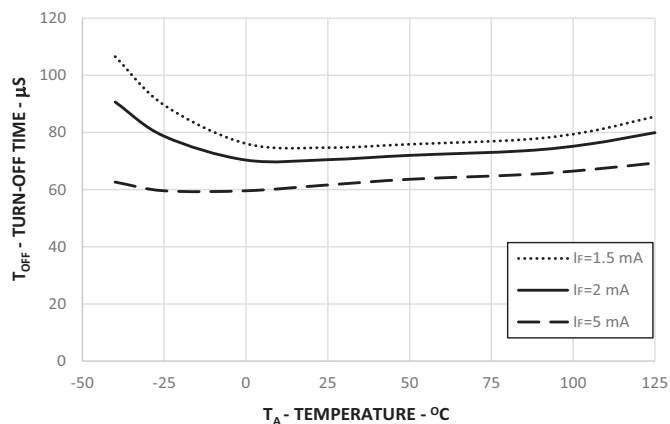
**Figure 8: On-Resistance vs. Temperature**



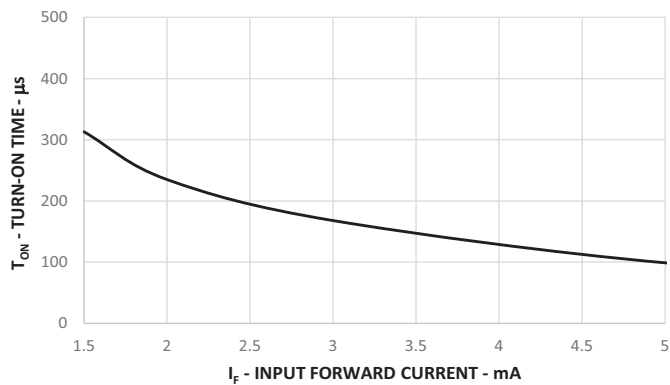
**Figure 9: Turn-On Time vs. Temperature**  
(Test Condition:  $V_{DD} = 40\text{V}$ ,  $R_{LOAD} = 20 \text{ k}\Omega$ )



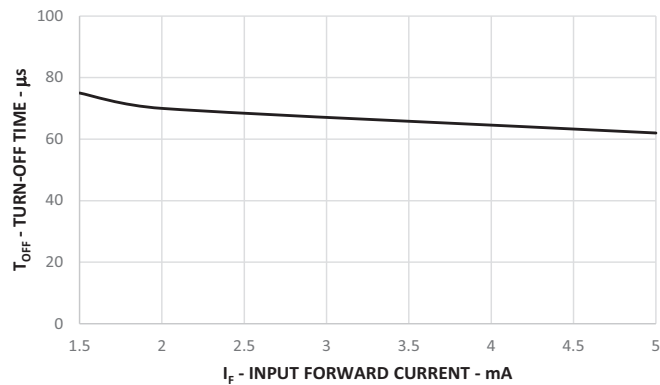
**Figure 10: Turn-Off Time vs. Temperature**  
(Test Condition:  $V_{DD} = 40\text{V}$ ,  $R_{LOAD} = 20 \text{ k}\Omega$ )



**Figure 11: Turn-On Time vs. Input Forward Current**  
(Test Condition:  $V_{DD} = 40\text{V}$ ,  $R_{LOAD} = 20 \text{ k}\Omega$ )



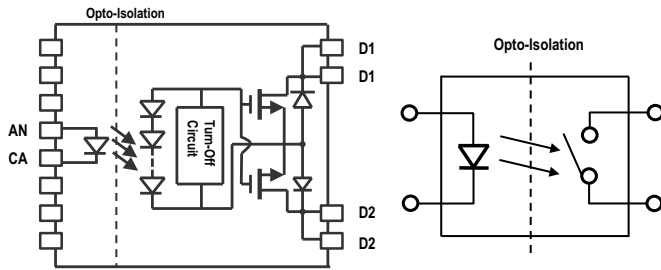
**Figure 12: Turn-Off Time vs. Input Forward Current**  
(Test Condition:  $V_{DD} = 40\text{V}$ ,  $R_{LOAD} = 20 \text{ k}\Omega$ )



## Application Note

APML-600JV/JT is a single-channel PhotoMOSFET that is equivalent to 1 Form A electromechanical relay (EMR) as shown in Figure 13. It functions like a bidirectional switch with no output power requirement. The input side is LED-driven and can be turned on with minimum input current of 1.5 mA.

Figure 13: Equivalent Relay Diagram



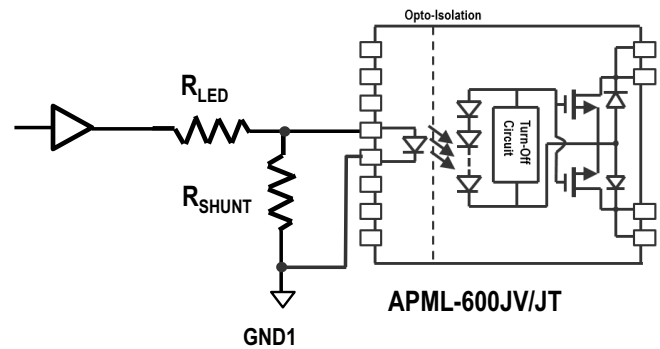
The input LED is optically coupled through a photodiode stack and driver circuit to switch two high voltage MOSFETs. When current is driven into the LED, the light generates photocurrent on the photodiode to charge the gate of the MOSFETs, to switch and keep the power device on.

## Preventing Accidental LED Turn-On

In order to prevent the accidental turn-on of the LED due to leakage current in the input, it is recommended to have a definite threshold input current for the LED. This threshold adjustment can be obtained by shunting the LED by a resistor ( $R_{SHUNT}$ ), the value of which is determined by a ratio between the Input Threshold Current ( $I_{FT}$ ) and Maximum Input LED Turn-Off Voltage ( $V_{F(OFF)MAX}$ ). The following circuit shows the relationship between these values. The calculations will determine the shunt resistor value required for a given  $I_{FT}$  and  $V_{F(OFF)MAX}$ .

In the following example, the maximum LED Turn-Off voltage is 0.4V (from Absolute Maximum Specification) and the Input Threshold current is set to 100  $\mu$ A. The required shunt resistor value is 4 k $\Omega$ . In this example, when LED is ON, there will be a typical current value of 350  $\mu$ A flowing through the shunt resistor.

Figure 14: Shunt Resistor on the Input



$$R_{SHUNT} = \frac{V_{F(OFF)MAX}}{I_{F(THRESHOLD)}}$$

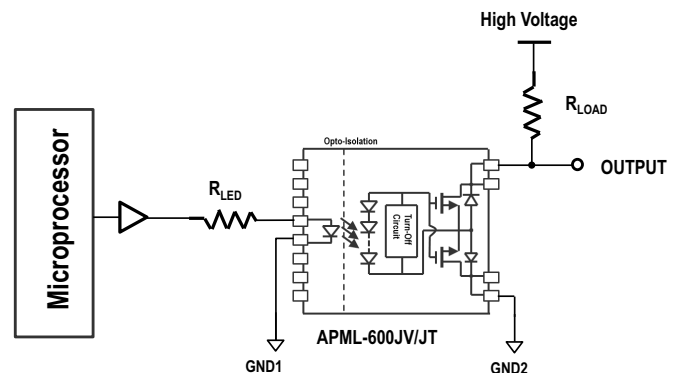
$$= \frac{0.4V}{100\mu A}$$

$$R_{SHUNT} = 4k\Omega$$

The following typical application circuit shows the APML-600JV/JT input being controlled by the microprocessor to switch the output (high voltage side). The APML-600JV/JT galvanic isolation protects the low voltage side of the circuit (input) from the high voltage side (output).

Pins 8 to 9 and 15 to 16 are internally connected. In routing the PCB layout, either of the pins can be used. Shorting the pins (8 to 9) and (15 to 16) is also acceptable.

Figure 15: Typical Application Circuit

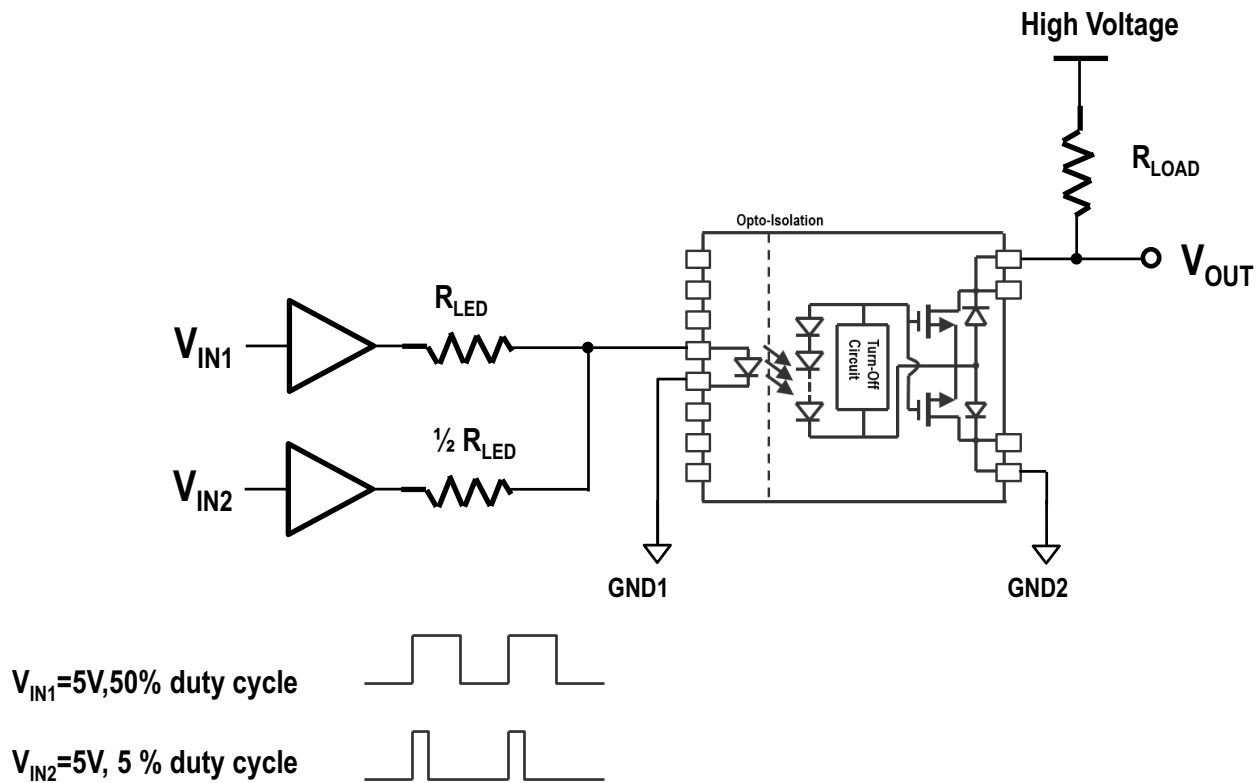


## Turn-On Time

$T_{ON}$  is influenced by the level of input current. As input current is increased, the  $T_{ON}$  becomes shorter. In a situation where  $T_{ON}$  needs to be shorter than what the maximum level of input current can achieve, peaking can be implemented as shown in the following figure.

In this peaking circuit, the LED can be driven by the two inputs to achieve shorter  $T_{ON}$ . The duty cycle of the second input  $V_{IN2}$  must be set lower in order to achieve the peaking effect.

Figure 16: Peaking Circuit



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